

14.08.2023

0	14.082023	New release.	WYC	LSB

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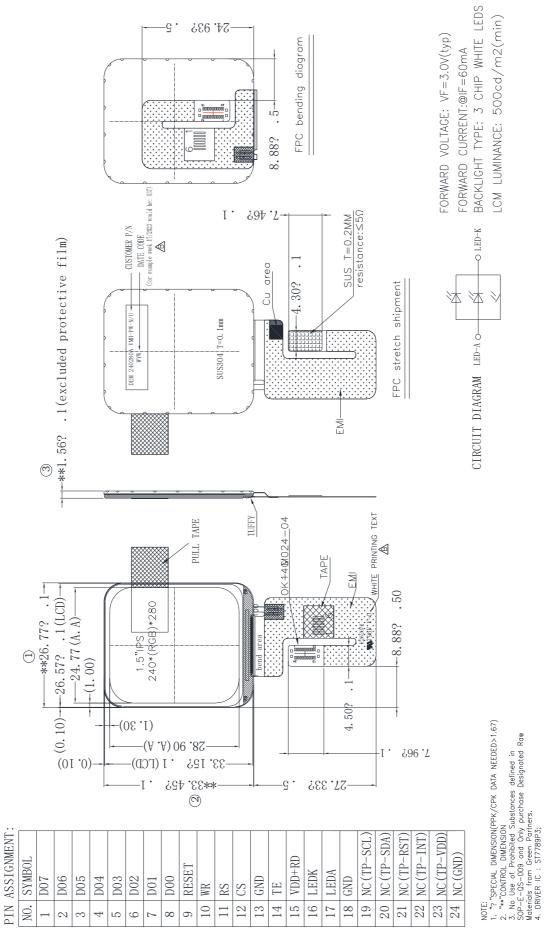
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1.0 GENERAL SPECIFICATION

Item	Contents	Unit
Display Mode	1.5" TFT Transmissive / IPS / Normally Black	-
Module Outer Dimension	26.77 x 33.45 x 1.56 (Excluded FPC length)	mm
Pixel Size	0.1032 x 0.1032	mm
Active Area	24.77 x 28.90	mm
Number of Dots	240 x RGB x 280	dots
Viewing Direction	All Directions	O'clock
Pixel Arrangement	RGB Vertical Stripe	-
Backlight	LED White Backlight	-
Driver IC	ST7789P3 (Sitronix)	-
Interface Type	8-Bit-MCU	-
Number Of Colors	262k	-
Operating Temperature	-20 ~ 70	°C
Storage Temperature	-30 ~ 80	°C

Remarks: Normal Operating Condition is Temperature 15°C ~ 35°C, Humidity 45%RH ~ 75%RH, Atmospheric Pressure 86kPa ~ 106kPa.

2.0 OUTLINE DRAWING

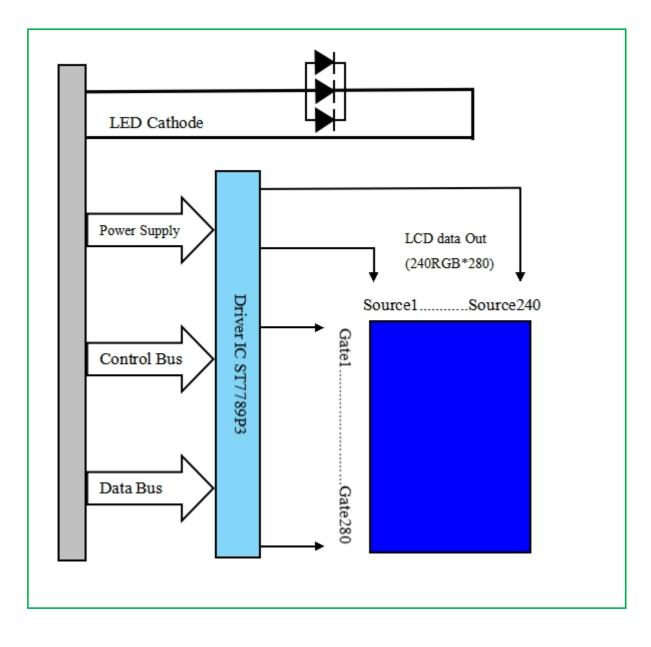


Version: 0

3.0 INTERFACE PIN DESCRIPTION

Pin No.	Symbol	Pin Description					
1	D07						
2	D06						
3	D05						
4	D04	MCU Parallel Interface Data Bus.					
5	D03	MCO Parallel Interface Data Bus.					
6	D02						
7	D01						
8	D00						
9	RESET	Reset Signal Input Pin					
10	WR	Write enable pin					
11	RS	Display data/command selection pin					
12	CS	Chip selection pin,Low-active					
13	GND	Ground					
14	TE	Tearing effect pin					
15	VDD+RD	Power supply voltage					
16	LEDK	LED backlight cathode.					
17	KEDA	LED backlight anode.					
18	GND	Ground					
19	NC(TP-SCL)	No connection.					
20	NC(TP-SDA)	No connection.					
21	NC(TP-RST)	No connection.					
22	NC(TP-INT)	No connection.					
23	NC(TP-VDD)	No connection.					
24	NC(GND)	No connection.					

4.0 BLOCK DIAGRAM



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5.0 **OPERATING PRINCIPLE & DRIVING METHOD**

5.1 Please refer to ST7789P3 (V1.0) IC data sheet.

5.2 Instruction Description (based on IC spec ver as stated in 6.1 where the product is designed). This instruction description is for reference only. Customer is encouraged to always refer to the latest IC specification when developing application system platform.

5.3 **Recommended initial codes**

void LCD Init(void) //----reset LCD RST=1: Delay ms(1); RST=0; Delay ms(10); RST=1; Delay ms(120); WriteComm(0xB2); WriteData(0x00,0x0C); //porch setting WriteData(0x00,0x0C); WriteData(0x00,0x00); WriteData(0x00,0x33); WriteData(0x00,0x33); WriteComm(0xB7); WriteData(0x00,0x00); WriteComm(0xBB); WriteData(0x00,0x2C); //VCOM WriteComm(0xC2); WriteData(0X00,0x01); WriteComm(0xC3); WriteData(0X00,0x01); //GVDD WriteComm(0xC4); WriteData(0X00,0x20); //VDV WriteComm(0xE4); WriteData(0x00,0x25); WriteData(0x00,0x00); WriteData(0x00,0x10); WriteComm(0xD0); WriteData(0X00,0xA4); WriteData(0X00,0xA2); //AVDD&AVCL WriteComm(0xD2); WriteData(0x00,0x4C); //enable VAP VAN

WriteComm(0xE8);

WriteData(0X00,0x83); //Booster CLK Select

WriteComm(0xE9); WriteData(0x00,0x09); //EQ WriteData(0X00,0x09); WriteData(0X00,0x08);

WriteComm(0x36); WriteData(0x00,0x00); //ACCESS

WriteComm(0x34);

WriteComm(0x3A); WriteData(0x00,0x06); //18bit

WriteComm(0xC6); WriteData(0x00,0xF0);

//gamma

WriteComm(0xE0); WriteData(0x00,0xD2); WriteData(0x00,0x09); WriteData(0x00,0x0E); WriteData(0x00,0x09); WriteData(0x00,0x25); WriteData(0x00,0x25); WriteData(0x00,0x33); WriteData(0x00,0x33); WriteData(0x00,0x42); WriteData(0x00,0x11); WriteData(0x00,0x29); WriteData(0x00,0x20);

WriteComm(0xE1); WriteData(0x00,0xD2); WriteData(0x00,0x09); WriteData(0x00,0x0E); WriteData(0x00,0x09); WriteData(0x00,0x25); WriteData(0x00,0x25); WriteData(0x00,0x33); WriteData(0x00,0x36); WriteData(0x00,0x11); WriteData(0x00,0x29); WriteData(0x00,0x20);

WriteComm(0x21);

}

WriteComm(0x11); WriteComm(0x29);

- <u>Notes:</u>
 1) These initial codes are only for reference, Customer should optimize above setting according to the display pattern and application used.
- 2) Customer is advised to refer to "General Handling Precaution of LCD Modules" section in this product specification regarding the operating precaution of LCD modules, when optimizing the display initialization setting.
- 3) DISPLAY Elektronik GmbH will use above initial code for production testing by default. Customer is advised to highlight to DISPLAY Elektronik GmbH in case that initial code setting in customer application is different with above initial code. Reason is to ensure DISPLAY Elektronik GmbH testing is in-line with customer application as close as possible for good quality control.

5.4 Power On/Off Sequence

VDDI and VDD can be applied in any order.

In CABC function application, VDDI power on need delay 5ms after VDD has been supplied.

VDD and VDDI can be power down in any order.

During power off, if LCD is in the Sleep Out mode, VDD and VDDI must be powered down minimum 120msec after RESX has been released.

During power off, if LCD is in the Sleep In mode, VDDI or VDD can be powered down minimum 0msec after RESX has been released.

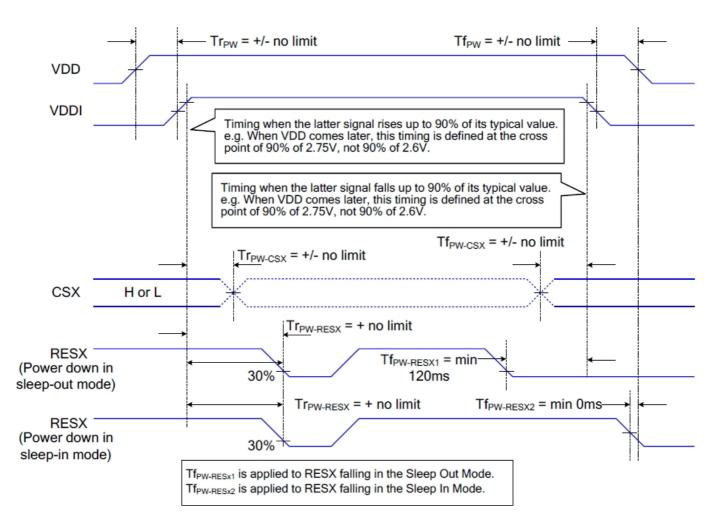
CSX can be applied at any timing or can be permanently grounded. RESX has priority over CSX.

- Note 3: There will be no abnormal visible effects on the display between end of Power On Sequence and before receiving Sleep Out command. Also between receiving Sleep In command and Power Off Sequence.
- Note 4: If RESX line is not held stable by host during Power On Sequence as defined in the sequence below, then it will be necessary to apply a Hardware Reset (RESX) after Host Power On Sequence is complete to ensure correct operation. Otherwise function is not guaranteed.

The power on/off sequence is illustrated below

Note 1: There will be no damage to the display module if the power sequences are not met.

Note 2: There will be no abnormal visible effects on the display panel during the Power On/Off Sequences.

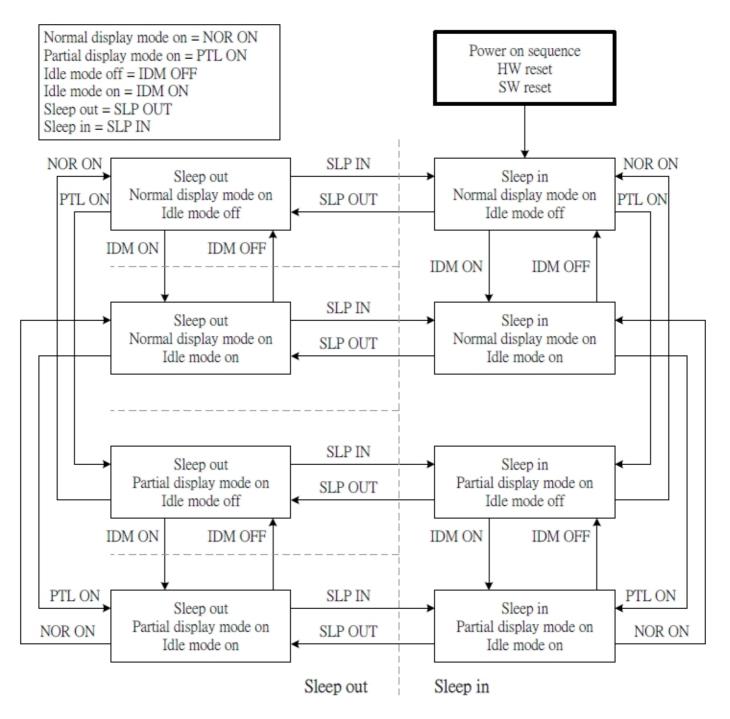


8.15.1 Uncontrolled Power Off

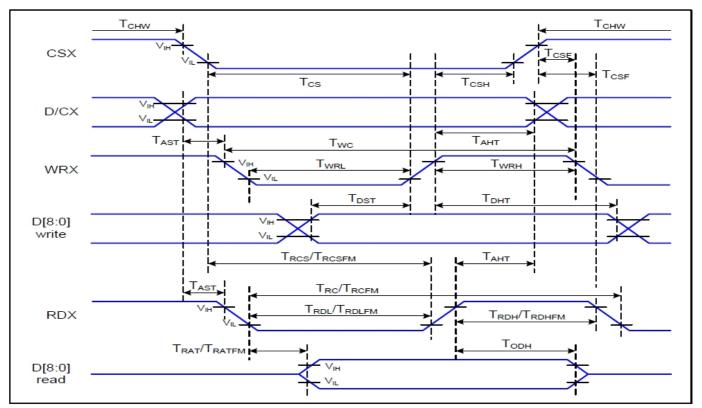
The uncontrolled power-off means a situation which removed a battery without the controlled power off sequence. It will neither damage the module or the host interface.

If uncontrolled power-off happened, the display will go blank and there will not any visible effect on the display (blank display) and remains blank until "Power On Sequence" powers it up.

5.5 Power Flow Chart



5.6 Timing Characteristics



7.4.1 8080 Series MCU Parallel Interface Characteristics: 9/8-bit Bus

Figure 1 Parallel Interface Timing Characteristics (8080-Series MCU Interface)

Signal	Symbol	Parameter	Min	Мах	Unit	Description
D/CX	TAST	Address setup time	0	-	ns	
DICX	Тант	Address hold time (Write/Read)	10	-	ns	-
	Тснw	Chip select "H" pulse width	0	-	ns	
	Tcs	Chip select setup time (Write)	15	-	ns	
CSX	T _{RCS}	Chip select setup time (Read ID)	45	-	ns	
007	TRCSFM	Chip select setup time (Read FM)	355	-	ns	-
	TCSF	Chip select wait time (Write/Read)	10	-	ns	
	Тсян	Chip select hold time	10	-	ns	
	Twc	Write cycle	66	-	ns	
WRX	TWRH	Control pulse "H" duration	15	-	ns	-
	TWRL	Control pulse "L" duration	15	-	ns	
	T _{RC}	Read cycle (ID)	160	-	ns	
RDX (ID)	TRDH	Control pulse "H" duration (ID)	90	-	ns	When read ID data
		Control pulse "L" duration (ID)	45	-	ns	
RDX	TRCFM	Read cycle (FM)	450	-	ns	When read from
(FM)		Control pulse "H" duration (FM)	90	-	ns	
(FIVI)	TRDLFM	Control pulse "L" duration (FM)	355	-	ns	frame memory
D[8:0]	TDST	Data setup time	10	-	ns	For CL=30pF
	TDHT	Data hold time	10	-	ns	
	T _{RAT}	Read access time (ID)	-	40	ns	
	TRATEM	Read access time (FM)	-	340	ns	
	Торн	Output disable time	20	80	ns	

VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=25 $^{\circ}\!\!C$

Table 4 8080 Parallel Interface Characteristics

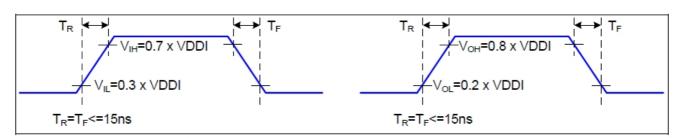


Figure 2 Rising and Falling Timing for I/O Signal

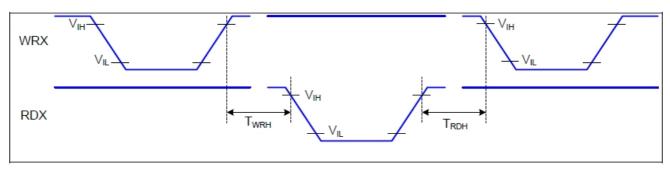
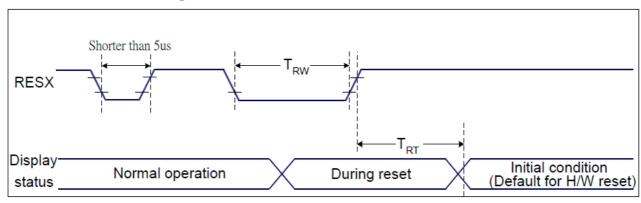


Figure 3 Write-to-Read and Read-to-Write Timing

Note: The rising time and falling time (Tr, Tf) of input signal and fall time are specified at 15 ns or less. Logic high and low levels are specified as 30% and 70% of VDDI for Input signals.



7.4.5 Reset Timing:

Figure 7 Reset Timing

VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=25℃

Related Pins	Symbol	Parameter	MIN	MAX	Unit
	TRW	Reset pulse duration	10	-	us
RESX	TRT	Peast served	-	5 (Note 1, 5)	ms
		Reset cancel	-	120 (Note 1, 6, 7)	ms

Table 8 Reset Timing

Notes:

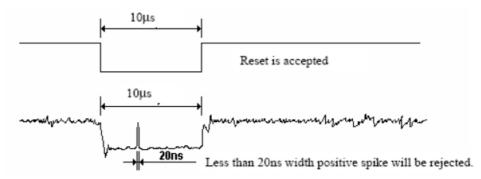
1. The reset cancel includes also required time for loading ID bytes, VCOM setting and other settings from NVM (or similar device) to registers. This loading is done every time when there is HW reset cancel time (tRT) within 5 ms after a rising edge of RESX.

2. Spike due to an electrostatic discharge on RESX line does not cause irregular system reset according to the table below:

RESX Pulse	Action		
Shorter than 5us	Reset Rejected		
Longer than 9us	Reset		
Between 5us and 9us	Reset starts		

3. During the Resetting period, the display will be blanked (The display is entering blanking sequence, which maximum time is 120 ms, when Reset Starts in Sleep Out –mode. The display remains the blank state in Sleep In –mode.) and then return to Default condition for Hardware Reset.

4. Spike Rejection also applies during a valid reset pulse as shown below:



5. When Reset applied during Sleep In Mode.

6. When Reset applied during Sleep Out Mode.

7. It is necessary to wait 5msec after releasing RESX before sending commands. Also Sleep Out command cannot be sent for 120msec.

6.0 ABSOLUTE MAXIMUM RATINGS (Ta = 25°C, Vss = 0 V)

Parameter	Symbol	Min	Тур.	Max	Unit
Supply Voltage for Logic	V_{DD}	-0.3	-	4.0	V
Driver Supply Voltage	VGH-VGL	-0.3	-	30	V
Input Voltage	V _{IN}	-0.3	-	4.0	V
Output Voltage	Vo	-0.3	-	4.0	V
Operating Temperature	Тор	-20	-	70	°C
Storage Temperature	Tst	-30	-	80	°C

7.0 ELECTRICAL CHARACTERISTICS (Ta = 25°C, Vss = 0 V, VDD=2.75V)

Parameter	Symbol	Condition	Min	Тур.	Мах	Unit
System Voltage	V _{DD}	-	2.4	2.75	3.3	V
Gate On Power	VGH	-	-	(12.2)	-	V
Gate Off Power	VGL	-	-	(-7.16)	-	V
Vcom	Vcom	-	-	0	-	V
Logic High Input Voltage	VIH	-	0.7V _{DD}	-	V _{DD}	V
Logic Low Input Voltage	VIL	-	Vss	-	$0.3V_{\text{DD}}$	V
Logic High Output Voltage	V _{OH}	IOH=-1.0mA	$0.8V_{DD}$	-	V_{DD}	V
Logic Low Output Voltage	Vol	IOL= +1.0mA	Vss		$0.2V_{\text{DD}}$	V
LCM Supply Current	I _{LCM}	-	-	6.7	10	mA

8.0 ELECTRO-OPTICAL CHARACTERISTICS (Ta = 25°C, Vss = 0 V, VDD=2.75V)

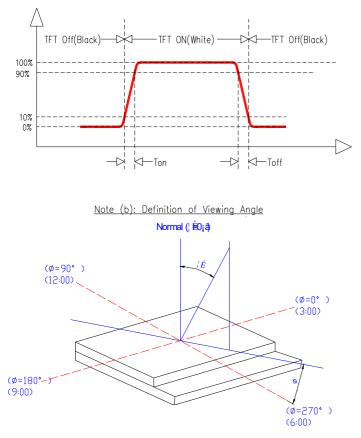
No	ltem		Symbo I	Condi	Condition		Тур.	Max.	Unit	Note	
1	Response Tir	me	T_{on} + T_{off}	$\theta = \phi =$	= 0º	-	35	40	ms	(a)	
2	Contrast Rat	lio	CR	$\theta = \phi =$	= 0º	800	1000	-	-	(c)	
			3:00	$\phi = 0$)°	70	80	-	Deg		
3	Viewing Ang	le	9:00	φ = 18	30°	70	80	-	Deg	(b)	
3	(CR ≥ 10)		12:00	φ = 9	0°	70	80	-	Deg	(b)	
			6:00	φ = 270°		70	80	-	Deg		
4	Brightness on LCM	1	L _{LCM}	$\begin{array}{c c} \theta = 0^{\circ} \\ \phi = 0^{\circ} \end{array} 25 \circ C$		500	550		cd/m 2	(d)	
		White	Wx			0.25	0.30	0.35	-	-	
	Color	VIIIco	· · · · · · · ·	Wy			0.28	0.33	0.38	-	-
	Chromaticity	Ded	Rx			0.52	0.57	0.62	-	-	
5	(Center point of LCM)	Red	Ry	θ=0°, φ=	0°	0.28	0.33	0.38	-	-	
	(CIE1931)	Cream	Gx	Ta=25°C		0.316	0.366	0.416	-	-	
		Green	Gy			0.524	0.574	0.624	-	-	
		Dhua	Bx			0.100	0.150	0.200	-	-	
	Blue		Ву			0.065	0.115	0.165	-	-	
6	NTSC	•		46.3%		•		1			

Remarks:

1) EOC data above is measured using DMS-501 display measurement system.

2) Brightness data is measured using photometer Topcon BM-7.

Note(a): Definition of Response Time

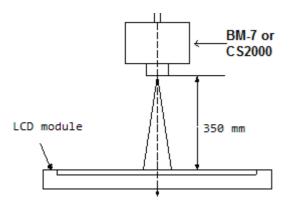


Note (c): Definition of Contrast Ratio

CR = Brightness at all pixels "White" / Brightness at all pixels "Black"

<u>Note (d): backlight driving condition: If = 60mA</u> <u>Luminance measuring point: Center of the dot matrix under white pattern</u>

measuring setup as below figure:



9.0 BACKLIGHT SPECIFICATION

9.1 LED Backlight Electrical-optical characteristics	S
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Item of backlight characteristics	Symbol	Min	Тур	Max	Unit	Condition
Forward Voltage	V_{f}	2.8 3.0 3.4 V		1.If=60mA, T=25°C 2.Aperture:0.2°,5 Points		
Uniformity	Δ	80	-	-	%	3.Average=min/max*10 0%
Number of LED	-	3 Piece				-
Connection Mode	S/P/M	3P -				-
LED Lifetime		Hrs (When n to 50% at inte	 1.Ta=25°C±5°C, RH=60% ± 10%; If=20mA/LED 2.No other Interference, such as Current, Voltage suddenly rise, Electrostatic shock, etc. 			

Remarks: chromaticity and luminance data are measured using photometer Topcon BM-7.

10.0 RELIABILITY SPECIFICATION

10.1 Reliability Test Conditions

No	Test Item	Test Conditions
1	High Temperature Storage	+80°C, 240hrs
2	High Temperature Operation	+70°C, 240hrs
3	Low Temperature Storage	-30°C, 240hrs
4	Low Temperature Operation	-20°C, 240hrs
5	High Temperature Humidity Operation	+40°C, 90%RH, 240hrs
6	Temperature Cycling Storage	$-30^{\circ}C\pm 2^{\circ}C(30min) \sim 25^{\circ}C(5min) \sim 80^{\circ}C\pm 2^{\circ}C(30min), 10Cycle.$
7	Vibration Test (Packaging)	Frequency:10-55Hz , Amplitude:0.75mm, x,y,z every direction for 0.5 hour
8	Drop Test (Packaging)	Drop to the ground from 80cm height, 6 side of carton, each once

Remarks:

1) For operation test, above specification is applicable when test pattern is changing during entire operation test.

2) Inspections after reliability tests are performed when the display temperature resumes back to room temperature.

3) It is a normal characteristic that some display abnormality can be seen during reliability test. If the display abnormality can recover as normal condition within 24 hours at room temperature, there is no permanent destruction over the display. The display still possesses its functionality and considered as acceptable after reliability tests.

10.2 Failure Judgment Criteria

After the reliability tests above, test sample shall be let return to room temperature and humidity for at least 4 hours before final tests are carried out.

Item	Acceptance Criteria
Electrical Characteristic	No electrical short and open.
	Increase in current consumption is less than 2 times of initial value.
Mechanical Characteristic	Within mechanical and drawing specification
	Within appearance standard as specified in this specification.
Optical Characteristic	Contrast ratio change & ON-transmission value shall not less than 50% of
	initial value.

11.0 QUALITY SPECIFICATION

11.1 Acceptable Quality Level (AQL)

Each lot should satisfy the quality level defined as follows:

- a) Inspection method: MIL-STD-105E Level II normal once sampling
- b) AQL level

	.,	
Category	AQL	Definition
Major	0.25%	Functional defective as product
Minor	0.25%	Satisfy all functions as product but not satisfy cosmetic standard

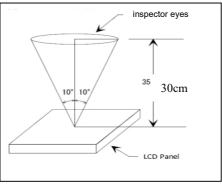
11.2 Conditions of Inspection

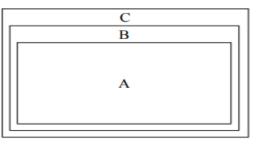
a) Function Inspection

- a) Inspection illumination: Function illumination<150Lux;Appearance illumination is 2500±500Lux.
- b) Inspection distance: About 30cm between the observer's eyes and the LCD.
- c) Inspection angle: Normal inspection angle is $\pm -10^{\circ}$ form LCD.

(Ghost shadow inspection angle is +/-45 $^\circ~$; Light leakage inspection angle is+/-30 $^\circ~$)

d) Inspection environment: normal temperature (18~27°C) and normal humidity (50~85%RH)





- A: viewing area
- B: viewing area except A
- C: Outside viewing area

Note: As a general rule, visual defects in C is permissible, when it is no trouble for quality and assembly of customer's product.

11.3 Acceptance Criteria (DISPLAY internal standard: IS-QC- 089(E)TFT-1)

	a) Function inspection			
ltem	Acceptance/Rejection Criteria	Classifica tion	Method	Method
Functional	 No-display /abnormal display/line defect etc. are not acceptable. Obvious color deviation in dark/red/green/blue screen is not acceptable. (refer limit sample if application) Obvious color deviation in the same screen is not acceptable. (spot, mura which cannot be seen by ND6 % is acceptable; Judgement Methods: The distance from the panel to ND filter paper: 350-400 - mm , put the ND filter paper in 1-2 cm distance away from the eye position, using monocular observation) The standard of eye Sight for Spot, Mura bad: put the filter paper in the positon in accordance with 3.0, move the eye sight away from the filter paper and turn the sight back to the filter paper. The standard of inspection time for spot, Mura:5 seconds. Current consumption (Idd MAX) shall not exceed the limit specified on the Test Instruction. Display character/ pattern shall be referred to the Test Instruction. Obvious light leakage is not acceptable. 	Major	Visual	A

Production Specification

Item		Acceptar	nce/Rejection Crit	eria		Classifica tion	Method	Method
Spot Foreign Particle , Dirt under POL or TP	Length D=(Length	+Width)/2	Zone Size(mm) D≤0.15 0.15 <d≤0.2 D>0.2</d≤0.2 	Acc No Unlimited 3 0		_ Major	Visual (Scale magnifying glass)	A、B、 C
Line defect: foreign or Scratch		Defect Foreign body、Pit Polarizer fibrous foreign body BL fibrous foreign body	Size(mm) W≤0.02 0.02 W≤0.05 and L≤4.0 W≥0.05 W≤0.02 0.02 W≤0.05 and L≤4.0 W≥0.05 W≤0.02 0.02 U≤0.05 and L≤4.0 W≥0.05	Acc A、B Unlimited 2 (distance ≥5mm) Define as s Unlimited 2 (distance ≥5mm) Define as s Unlimited 2 (distance ≥5mm) Define as s	C Unlimited pot defect Unlimited	Minor	Visual (Scale magnifying glass)	A、B、 C
Polarizer Air or TP film bubble	N/A		Size(mm) D≤0.15 0.15 <d≤0.2 0.2<d≤0.25 D>0.25</d≤0.25 </d≤0.2 	Acc A、B Unlimited 3 1 0	•	Minor	Visual (Scale magnifying glass)	A、B、 C
Light dot Dark dot Definition	 1). Pixel definition: Pixel is made of three sub-pixels (Red + Green +Blue) 2). Dot definition: Dot is a sub-pixel (Red or Green or Blue) 3). Light / Dark dot definition: A sub-pixel is on or off when the function testing. Light dot appears in dark picture usually. Dark dot appears in R\G\B color picture or the white picture usually. 4). Adjacent dot definition: Adjacent dot is made of two or three sub-pixels(R+G or G+B or B+R or R+G+B); 					Minor	Visual (Scale magnifying glass)	A
Bright dot/dark dot	 If the bright/dark dot size is less than 1/2 size of sub- pixel, ignore the dot. If the bright/dark dot size is equal or more than 1/2 size of sub-pixel, follow the acceptable number of dot defect specified in the table on the right. Bright dot 	Defect light dot light dot two- connection dark dot dark dot two- connection dark dot three- connection	Acc No. 3 1 3 1 3 1 3 ≤3	Rem 0 vertical and connetion are 1 vertical and connetion are 1 a two-connect as 2 o	d diagonal not allowed d diagonal not allowed	Minor	Visual (Scale magnifying glass) See the judgement method as below 350~400m NDistr panel 1.0 ND filter paper judgement method for	A

ltem	Acceptance/Rejection Criteria	Classifica tion	Method	Method
Tiny Bright dot	cannot be seen by ND 5% shall follow the tiny bright dot inspection standard. 4.Bright dot/dark dot can be seen by ND5% press Acc Qty standard judgement. 5.Tiny Bright dot definition, The bright dot cannot be seen by ND 6%. Tiny bright dot judgement, If the bright dot cannot be seen with ND6%, the acceptable Number is unlimited. If the bright dot can be seen with ND6%, the acceptable Number shall ≤10.		bright dot and tiny bright dot: Distance from the ND filter paper to panel: 1-2 cm position, binocular observation 2.0The standard of eye-sight inspection for Bright dot and tiny Bright dot: put the filter paper in the position in accordance with 1.0, move the eye-sight away from the filter paper and then turn the sight back to the filter paper. The standard of inspection time for Light spot, Light spot 5 seconds.	
Distance, Defect number	* 1 Distance between two detects must be more than 5 mm. *2.Total number of defects ≤3.	Minor	Visual (Scale magnifying glass)	A

b) Appearance Inspection

ltem	Accepta	Acceptance/Rejection Criteria					Method
	A.General chip-out	x (mm)	y (mm)	z (mm)	-		
		≤4.0	Outside 1/3 S	Ignore			
					Minor	Visual (Scale magnifying glass)	Out of A
Chip-out		S: Innerborder line of the seal					
	B. Chip-out on the back of terminal ledge	x (mm) Ignore ≤4.0	y (mm) ≤0.3 ≤1/4L	z (mm) ≤1/2t ≤t	Minor	Visual (Scale magnifying glass)	Out of A
	C. Chip-out on the terminal ledge but not exactly on the ITO electrode.	x (mm) Lgnore ≤4.0	y (mm) ≤0.3 ≤1/4L	z (mm) ≤1/2t ≤t	Minor	Visual (Scale magnifying glass)	Out of A

Item		Accepta	ance/Rejection C	Criteria		Classifica tion	Method	Method
		The second secon						
	D. Chip-out on ITO ele		x (mm) Ignore ≤2.0 ≤3.0	y (mm) ≤0.3 ≤0.8 ≤0.5	z (mm) ≤1/2t ≤1/2t ≤t	Minor	Visual (Scale magnifying glass)	Out of A
	E. Chip-out at corner		x (mm) ≤3.0	≤3.0 or ≤1/4L (whichever is less)	≤T			
	F. Chip-out at corner	5	x (mm) ≤3.0	y (mm) ≤3.0	z (mm) ≤T	Minor	Visual (Scale magnifying	Out of A
	G. Bur	± z	Remark: L= co thickness glas			-	glass)	
	H. Crack line	Т	unlimited	≤0.2	≤t			
			Extended crac	ck is not allowed		Major	Visual	Out of A
Foreign			Zone	Acc	No.			
material、 Black			Size	_ Α, Β	С	Minor	Visual (Scale magnifying glass)	A
dot、 White dot、 Pit、Dent Bubble	Length D=(Length+Widtl	Width h)/2	D≤0.15 0.15< D≤0.2 D>0.2	Unlimited 3 0	Unlimit ed			
etc.			D> 0.2					
		Defect	Size	Acc	No.	4		
Foreign	w v	Foreign	(mm)	Α, Β	С		Visual	
Foreign material、		body、 Pit、	W≤0.02	Unlimited		Minor	(Scale	A
Bubble etc.	Polariz er fibrous foreign	er	0.02< W≤0.05 and L≤4.0	2 (distance ≥5mm)	Unlimit ed		magnifying glass)	
		body	W≥0.05					
Polarizer bubble or TP film			Size(mn)	Acc A _N B	C C	-		
		F	D≤0.15	Unlimited		1	Visual	
	N/A		0.15 < D≤0.2	3	Unlimited	Minor	Visual (Scale magnifying glass)	A、B、 C
bubble			0.2 < D≤0.25	1				
			D > 0.25	0				

Item	Acceptance/Rejection Criteria	Classifica tion	Method	Method
Distance	Distance between two detects must be more than 5 mm.	Minor	Visual (Scale magnifying glass)	A
LC bubble	Not acceptable.	Minor	Visual (Scale magnifying glass)	А
Polarizer	1.Polarizer dimension & position shall meet the requirement indicated on the drawing.2.Polarizer orientation shall meet the requirement indicated on the drawing. (Background color shall be consistent with the sample).	Minor	Visual (Scale magnifying glass)	Out of A
	1.Protective film separating in Active Area is not acceptable.			
Protective film	2.Fingerprint\ Massive dirt in the polarizer by protective film separating is not acceptable.	Minor	Visual (Scale magnifying glass)	All
FPC	3.Erasable smudginess must be cleaned, unerasable smudginess is allowed.		-	
cosmetic defect	According to IPC-6013A.	-	Visual	-
	1.Coating location shall meet the manufacturing instruction or drawing; Coating shall cover all terminal tracks.			
	2.RTV pin holes and bubble shall not cause ITO tracks exposed.			
	3.RTV foreign material shall not cause ITO short-circuit.			
RTV	4.Uncured coating is not acceptable.	Major	Visual	Out of A
(Tuffy)	5.RTV Coating cannot be damaged. (Include irregular deformation)			
	6.RTV coating shall not exceed the height of the polarizer. RTV coating shall not spread over to the polarizer or the interface components.			
	7.Massive dirt on the coating is not acceptable.			
	1. Backlight unit dimension and form shall meet the requirement on the drawing.	Major	caliper	Out of A
	2.Backlight not light up, or wrong lighting color is not acceptable.			
BLU	3. Acceptance criteria for dark spot, bright spot, and scratch mark shall refer to the spot defect and the line defect of the LCD.4. Uneven brightness in the Viewing Area Zone A is not acceptable. (Refer to the limit sample if applicable).			
	4.Light leak is not acceptable in main viewing direction. (Refer to the limit sample if applicable).	Minor	Visual	Out of A
	5. LCD shall not be lifted after assembly.			
	6.Backlight reflecting film can't separate with BL.			
Label	1.Label printing must clearly visible; fuzzy printing missing printing and pin hole are not allowed.			
Printing	2.Date lable on LCD cannot be more than 1mm over the BC edge and cannot seen after assembly	Minor	Visual	Out of A
The	1.The outer dimension shall meet the specification the drawing.	Major	caliper	Out of A
product shall be free of dirt.	2.The product shall be free of dirt.	Minor	Visual	Out of A

12.0 ENVIRONMENTAL SPECIFICATION

This product is designed, manufactured and compliant to below RoHS standard:

- 1. Cadmium and Cadmium Compounds
- 2. Hexavalent Chromium Compounds
- 3. Lead and Lead Compounds
- 4. Mercury and Mercury Compounds
- 5. Polybrominated Biphenyls (PBBs)
- 6. Polybrominated Diphenyl ethers (PBDEs)
- 7. Butyl benzyl phthalate (BBP)
- 8. Bis (2-ethylhexyl)phthalate (DEHP)
- 9. Dibutyl phthalate (DBP)
- 10. Diisobutyl phthalate(DIBP)

Less than 100ppm Less than 1000ppm Less than 1000ppm

13.0 GENERAL PRECAUTIONS FOR USING LCD MODULES

g Precaution Operation Precautions
 shock. LCD may be broken t of glass. Viewing angle can be adjusted by varying driving voltage, V₀ or Vop. Display performance may vary or show abnormal electro-optical performance when viewed at angle beyond the specified viewing angle range. Display performance may vary or show abnormal electro-optical performance when viewed at angle beyond the specified viewing angle range. Display color may change under extreme temperature. This is not destructive symptom and display color will resume back to normal when temperature goes back to normal temperature. Driving voltage shall be kept within the specified range as stated in this product specification. Over- voltage may shorten the LCD/LCM lifetime. No DC voltage to LCD/LCM will deteriorate under DC. Please control the DC content in application driving circuit. Avoid using the same display pattern for long time (continuous ON segment). It is a normal phenomena observed for passive driven display where image retention is observed when LCD is displayed with same pattern over 1 hour under temperature > 55°C. Customer is advised to design application software where display pattern will be changed from time to time, or using the N-line inversion function comes with the display driver IC. If the LCM is using master-slave configuration, customer is strongly recommended to use external Vo. If the LCM comes with MTP/OTP function, customer is recommended to use this MTP/OTP function for the best optical performance.
Electricity FPC cleanness
 Procidentities If ACF bonding is applied at customer side between FPC and PCB, cleaning on FPC and PCB bonding area (just before bonding) is a must to reduce risk of bonding reliability (eg bonding delamination/spring back phenomenon, low pull strength etc) Long-term Storage Conditions Store LCD/LCM in dark area and keep LCD/LCM away from direct sunlight and fluorescent light. Store LCD/LCM under temperature range of 0~35°C and room humidity of 50~60%RH. Possible Vop adjustment might be needed at customer side after prolong storage over 1 year from date of manufacturing.

14.0 APPENDIX

14.1 Functional testing pattern

Below test patterns will be used at all LCM functional tests at mass production stage. Acceptance of a product during inspection will be judged based on these test patterns only. Customer should notify DISPLAY Elektronik GmbH if different test patterns being used at customer side to ensure same testing platform between Customer and DISPLAY Elektronik GmbH, especially on those defects (flickering, image sticking, cross-talk, black/white line) which are pattern-dependent. These test patterns are by default agreed by both Customer and DISPLAY Elektronik GmbH, unless notified by Customer to revise such test patterns. If the defect listed in above description is seen in below pattern, LCD module should be judged as NG and vice versa.

1) White pattern:



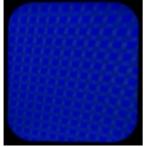
3) Frame pattern:



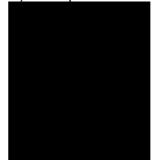
5) Red pattern:



7) Blue Pattern :



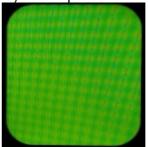
2) Black pattern:



4) Grey pattern:



6) Green pattern:



8) Gray scale Pattern :

